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Critical gradient model for fast-ion transport by Alfvén Eigenmodes (AE)

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The experiment is inspired by a successful DIII-D experiment

- Beam power scan varies AE amplitude
- Modulated off-axis beam allows measurement of incremental fast-ion flux
- Local fast-ion density ceases to rise above certain input power/ AE amplitudes
 - SSNPA Neutral particle analyzer -> fastion density localized in phase space





MW

MW

- Conditionally average the modulated signal
- Above threshold, the signal is strongly distorted by transport.

Recent Data Supports Critical Gradient Model of Alfven Eigenmode (AE) Induced Fast Ion Transport

- Beam power scan varied AE amplitude
- Modulated off-axis beam allowed measurement of EP pulse propagation and flux
- Local EP density ceases to rise above certain input power/ AE amplitudes
 - SSNPA Neutral particle analyzer -> EP density localized in phase space
- By fitting modulated waveforms, divergence of EP flux is obtained
- Divergence of flux shows abrupt change as AE power increases – indicative of critical gradient behavior





Implementation on NSTX-U

Active Beam (for SSNPA & FIDA): On constantly, must be either Source 1A or 1B. <u>Modulated Beam</u>: Not in SSNPA/FIDA sightlines \rightarrow either 2A, 2B, or 2C <u>Plasma</u> Reproducible density across power scan desired \rightarrow H-

<u>**Plasma</u>** Reproducible density across power scan desired \rightarrow mode</u>

<u>Fine Power Steps</u> Run one or more beams at lowered voltage

Runplan

- 1. Baseline condition
- a) Power level #3
- Good H-mode? (Adjust conditions)
- b) Try 1A/2B as low-power case
- AEs? (Choose FIDA/SSNPA beam)
- 2. Complete power scan
- 3. Power scan with different modulated source
- 4. Finer power scan near threshold

Power Scan

- 1. 1B/2B
- 2. 1B/2B/2C
- 3. 1B/2B/1A
- 4. 1B/2B/1A/2C
- 5. 1B/2B/1A/2A
- 6. 1B/2B/1A/2A/2C
- 7. 1B/2B/1A/2A/1C
- 8. 1B/2B/1A/2A/1C/2C

Diagnostics

Fast ion

SSNPA, FIDA, neutrons, SLIP

<u>Plasma</u>

MSE, Thomson

<u>AEs</u>

Magnetics, reflectometer

